

Application/Control No.	Applicant(s)/Patent under Reexamination
10/614,928	LEE, JIN-YUAN
Examiner	Art Unit
Douglas M. Menz	2829

SEARCHED						
Class	ss Subclass		Examiner			
257	700	3/14/05	DM			
	678					
	752					
	777					
	774					
	723					
	656					
	656 676	3/14/65	V)M			

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
257	700 678	3/14/05	VM		
	752 777				
	774 723				
	456	3/14/05	on		

SEARCH NOTES (INCLUDING SEARCH STRATEGY)					
	DATE	EXMR			
East Send US PAT, US PEPUB, US OCK EPO, JPO, Ornat, IBM TDB	2/22/05	DM			
Updated Sent	3/14/65	DM .			